

SEP 06 2005

Practitioner's Docket No.: 796\_007

PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: Takao OHNISHI, Toshikazu HIROTA and Shigeki  
KIRA

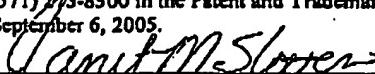
Serial No.: 10/023,455 Group Art Unit: 1743

Filed: December 17, 2001 Examiner: Ludlow, Jan M.

Conf. No.: 2269

For: METHOD OF FORMING DETECTION SPOTS ON AN ANALYTE  
DETECTION CHIPMail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

## CERTIFICATE OF FACSIMILE TRANSMISSION

I hereby certify that this paper is being facsimile transmitted to  
(571) 273-8300 in the Patent and Trademark Office on  
September 6, 2005.  
Janet M. Stevens

## AMENDMENT AFTER FINAL REJECTION

Sir:

*ok to enter*

In response to the Office Action mailed May 5, 2005, please amend the above-  
identified application as follows:

*MJ*  
*9/29/05*

Amendments to the Claims are reflected in the listing of claims which begins  
on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.

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